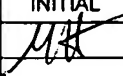
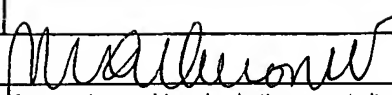


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250619US2SRD DIV		SERIAL NO. NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hideyuki FUNAKI			
				FILING DATE Herewith		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
MA	AA	5,880,921	3/9/99	J. L. Julian THAM, et al.			
	AB						
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
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	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
MA	AW	K. WANG, et al., "VHF Free-Free Beam High-Q Micromechanical Resonators", TECHNICAL DIGEST, 12TH INTERNATIONAL IEEE MICRO ELECTRO MECHANICAL SYSTEMS CONFERENCE, January 17-21, 1999, pgs. 453-458					
MA	AX	Paul M. Zavracky, et al., "Micromechanical Switches Fabricated Using Nickel Surface Micromachining", JOURNAL OF MICROELECTROMECHANICAL SYSTEMS, VOL. 6, NO. 1, March 1997, pgs. 3-9					
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>M. Walker</i>					Date Considered 05/3/05		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	6,153,839	11/2000	Zavracky et al.			
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner 					Date Considered 05/03/05		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							